



P-Channel 150-V (D-S) MOSFET

PRODU	PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
- 150	1.2 at V _{GS} = - 10 V	- 1.3	4.8 nC		
- 150	1.3 at V _{GS} = - 6 V	- 1.2			

FEATURES

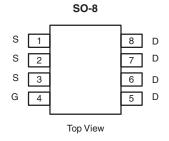
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % UIS Tested

COMPLIANT **HALOGEN**

FREE

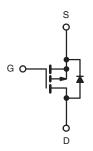
APPLICATIONS

- · Active Clamp Switch
- Isolated DC/DC Converters



Ordering Information: Si4409DY-T1-E3 (Lead (Pb)-free)

Si4409DY-T1-GE3 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 150	V	
Gate-Source Voltage		V _{GS}	± 20	
	T _C = 25 °C		- 1.3	
Continuous Proin Current (T. – 150 °C)	T _C = 70 °C		- 1.0	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 0.9 ^{b, c}	
	T _A = 70 °C		- 0.7 ^{b, c}	
Pulsed Drain Current		I _{DM}	- 2	Α
Ocation of Ocata	T _C = 25 °C		- 1.3	
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S -	- 0.9 ^{b, c}	
Avalanche Current	1 04	I _{AS}	4	
Single-Pulse Avalanche Energy L = 0.1 mH		E _{AS}	0.8	mJ
	T _C = 25 °C		4.6	
Maximum Power Dissipation	T _C = 70 °C		2.9	
	T _A = 25 °C	P _D	2.2 ^{b, c}	W
	T _A = 70 °C		1.4 ^{b, c}	
Operating Junction and Storage Temperature Rang	T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	47	55	°C/W	
Maximum Junction-to-Foot	Steady State	R_{thJF}	22	27		

Notes:

- a. T_C = 25 °C. b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 95 °C/W.

Vishay Siliconix



SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	I V	V 0.V I 050A	150	I	ı	1 1/	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	- 150			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 160		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			5.5			
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 2		- 4	V	
Gate-Source Leakage	I _{GSS}				± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 150 V, V _{GS} = 0 V V _{DS} = - 150 V, V _{GS} = 0 V, T _J = 55 °C			- 1 - 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = 130 \text{ V}, V_{GS} = 0 \text{ V}, 1J = 33 \text{ U}$ $V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 2		- 10	Α	
On-State Drain Current	-D(on)	V _{GS} = - 10 V, I _D = - 0.5 A		0.95	1.2	,,	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -6 \text{ V}, I_D = -0.5 \text{ A}$		1.0	1.3	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 0.5 A		2.2		S	
Dynamic ^b							
Input Capacitance	C _{iss}			332			
Output Capacitance	C _{oss}	V _{DS} = - 50 V, V _{GS} = 0 V, f = 1 MHz		25		pF	
Reverse Transfer Capacitance	C _{rss}			13			
Total Cata Chausa		$V_{DS} = -75 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -0.5 \text{ A}$		7.7	12	nC	
Total Gate Charge				4.8	7.5		
Gate-Source Charge	Q_gs	$V_{DS} = -75 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -0.5 \text{ A}$		1.5			
Gate-Drain Charge	Q _{gd}			2.5			
Gate Resistance	R_{g}	f = 1 MHz		9		Ω	
Turn-On Delay Time	t _{d(on)}			7	14		
Rise Time	t _r	$V_{DD} = -75 \text{ V}, R_{L} = 75 \Omega$		10	20	1	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 1 A, V_{GEN} = - 10 V, R_g = 6 Ω		16	30		
Fall Time	ì,	Ţ		9	18	1	
Turn-On Delay Time	t _{d(on)}			7	14	ns	
Rise Time	t _r	$V_{DD} = -75 \text{ V}, R_{L} = 75 \Omega$		10	20		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -1 \text{ A}, V_{GEN} = -6 \text{ V}, R_g = 1 \Omega$		13	25		
Fall Time	ì,			10	20		
Drain-Source Body Diode Characterist	ics						
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 1.3		
Pulse Diode Forward Current	I _{SM}				- 2.0	A	
Body Diode Voltage	V _{SD}	I _S = - 1 A, V _{GS} = 0 V		- 0.7	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			43	70	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 10 A dl/dt 100 A/v- T 05 00		95	150	nC	
Reverse Recovery Fall Time	t _a	$I_F = -1.2 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		40			
Reverse Recovery Rise Time	t _b	1		3		ns	

Notes:

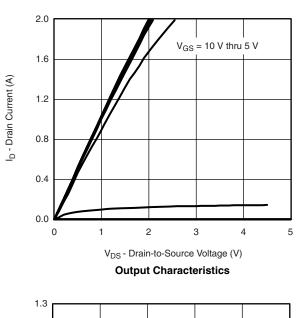
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

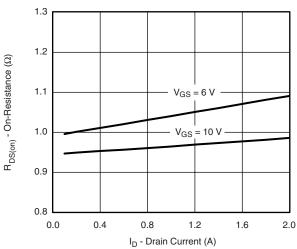
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

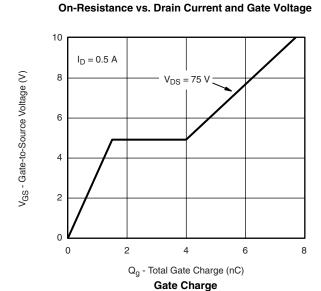


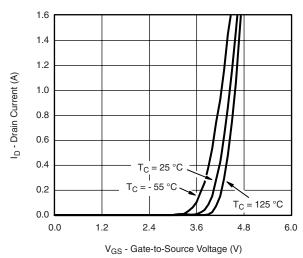


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

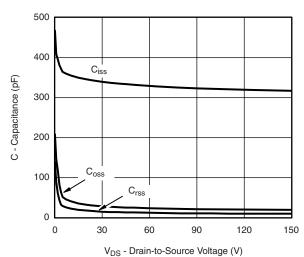




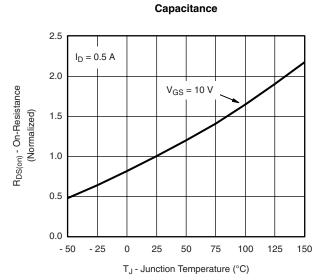




Transfer Characteristics



os - Diani-lo-Source voltage (v)

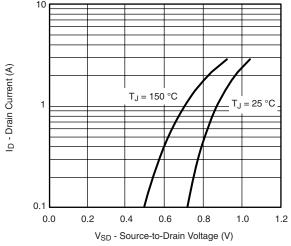


On-Resistance vs. Junction Temperature

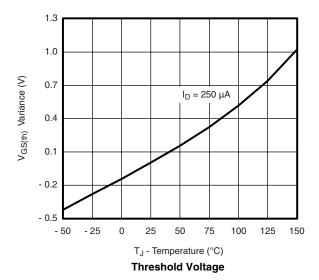
Vishay Siliconix

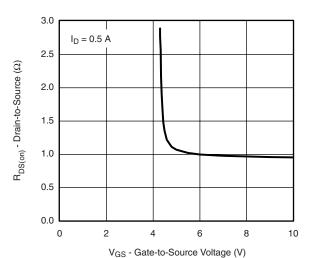
VISHAY

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

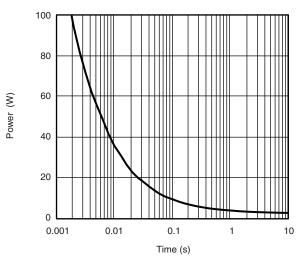


Source-Drain Diode Forward Voltage

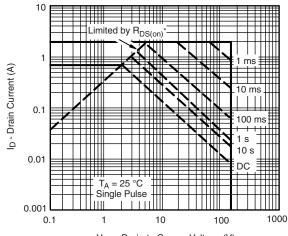




On-Resistance vs. Gate-to-Source Temperature



Single Pulse Power, Junction-to-Ambient

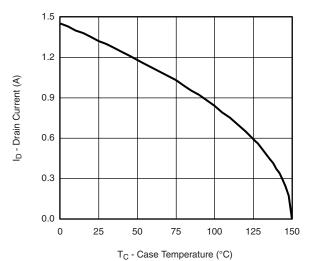


 $V_{DS} \mbox{ - Drain-to-Source Voltage (V)} \\ ^*V_{GS} \mbox{ > minimum } V_{GS} \mbox{ at which } R_{DS(on)} \mbox{ is specified}$

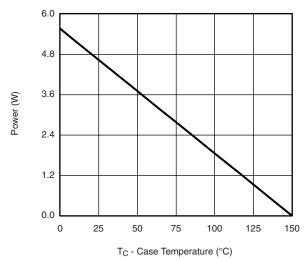
Safe Operating Area, Junction-to-Ambient

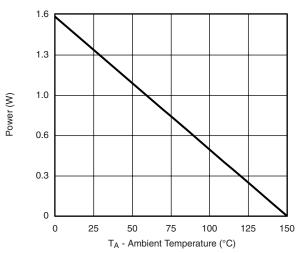


MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





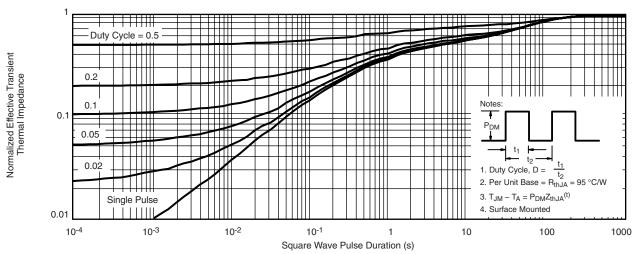
Power, Junction-to-Foot Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

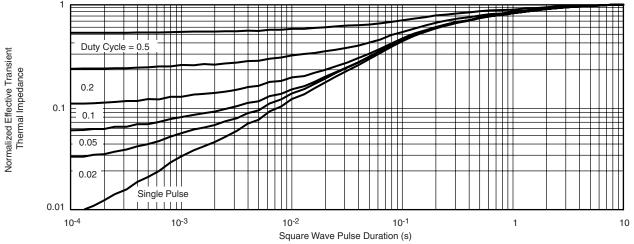
Vishay Siliconix

VISHAY.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?70485.

Legal Disclaimer Notice



Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Hyperlinks included in this datasheet may direct users to third-party websites. These links are provided as a convenience and for informational purposes only. Inclusion of these hyperlinks does not constitute an endorsement or an approval by Vishay of any of the products, services or opinions of the corporation, organization or individual associated with the third-party website. Vishay disclaims any and all liability and bears no responsibility for the accuracy, legality or content of the third-party website or for that of subsequent links.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.